

DESCRIPTION

The MAQ470 detects the absolute angular position of a permanent magnet, typically a diametrically magnetized cylinder on a rotating shaft. Fast data acquisition and processing provide accurate angle measurement at speeds from 0 to 60,000 rpm.

The MAQ470 supports a wide range of magnetic field strengths and spatial configurations. Both end-of-shaft and off-axis (side-shaft mounting) configurations are supported.

The MAQ470 features magnetic field strength detection with programmable thresholds to allow sensing of the magnet position relative to the sensor for creation of functions such as the sensing of axial movements or for diagnostics.

On-chip non-volatile memory provides storage for configuration parameters, including the reference zero angle position, ABZ encoder settings, and magnetic field detection thresholds.

FEATURES

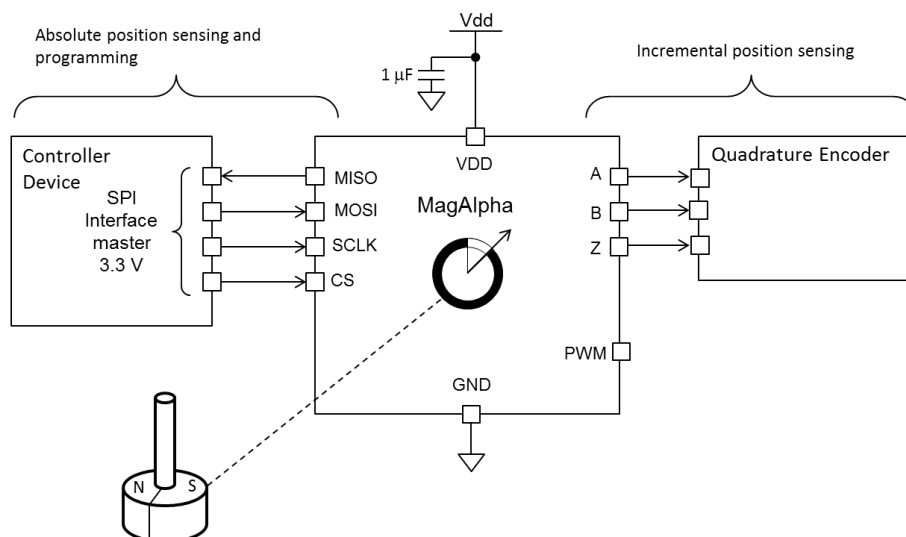
- 12-Bit Resolution Absolute Angle Encoder
- Contactless Sensing for Long Life
- AEC-Q100 Qualified
- Simple and Robust Design
- SPI Serial Interface with Parity Bit for Angle Readout and Chip Configuration
- Configuration Programmable Magnetic Field Strength Detection for Diagnostic Checks
- Incremental 10-Bit ABZ Quadrature Encoder Interface with Programmable Pulses Per Turn from 1-256
- PWM Output 12-Bit
- 3.3V, 12mA Supply
- -40°C to +150°C Operating Temperature
- Available in a QFN-16 (3mmx3mm) Package with Wettable Flanks

APPLICATIONS

- Automotive
- Angle Encoders
- Automotive Angle or Speed Sensors
- Robotics

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TYPICAL APPLICATION



ORDERING INFORMATION

Part Number*	Package	Top Marking
MAQ470GQE-AEC1	QFN-16 (3mmx3mm)	See Below

* For Tape & Reel, add suffix -Z (e.g. MAQ470GQE-AEC1-Z)

TOP MARKING

BDCY

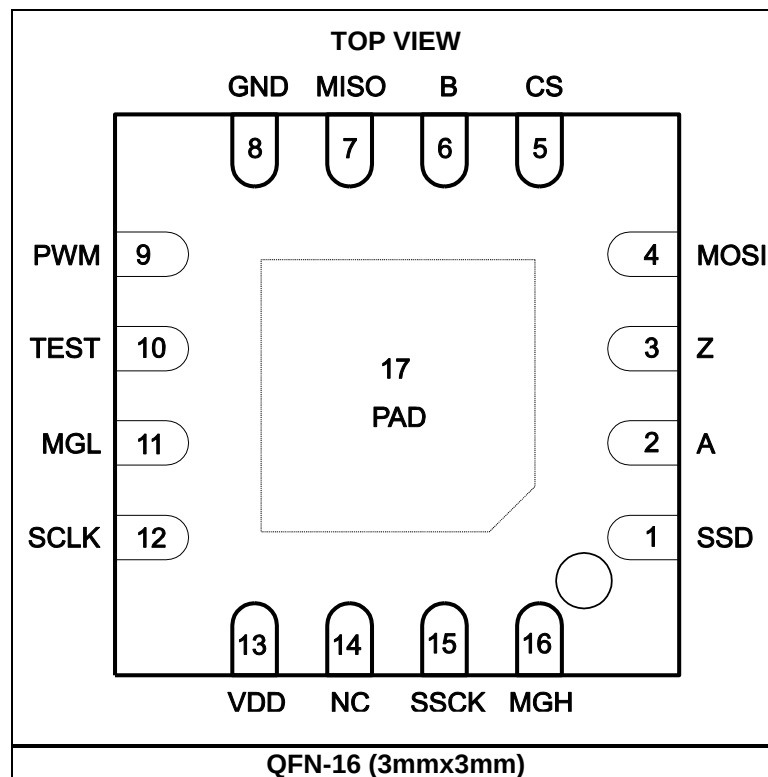
LLL

BDC: Product code of MAQ470GQE

Y: Year code

LLL: Lot number

PACKAGE REFERENCE



PIN FUNCTIONS

Package Pin #	Name	Description
1	SSD	Data out (SSI).
2	A	Incremental output.
3	Z	Incremental output.
4	MOSI	Data in (SPI). MOSI has an internal pull-down resistor.
5	CS	Chip select (SPI). CS has an internal pull-up resistor.
6	B	Incremental output.
7	MISO	Data out (SPI). MISO has an internal pull-down resistor that is enabled at a high impedance state.
8	GND	Supply ground.
9	PWM	PWM output.
10	TEST	Connect to ground.
11	MGL	Digital output indicating field strength below MGLT level.
12	SCLK	Clock (SPI). SCLK has an internal pull-down resistor.
13	VDD	Supply 3.3V.
14	NC	No connection. Leave NC unconnected.
15	SSCK	Clock (SSI). SSCK has an internal pull-down resistor.
16	MGH	Digital output indicating field strength above MGHT level.

ABSOLUTE MAXIMUM RATINGS ⁽¹⁾

Supply voltage	-0.5V to +4.6V
Input pin voltage (V _I)	-0.5V to +6.0V
Output pin voltage (V _O)	-0.5V to +4.6V
Continuous power dissipation (T _A = +25°C) ⁽²⁾	2.0W
Junction temperature	160°C
Lead temperature	260°C
Storage temperature	-65°C to 160°C

Thermal Resistance ⁽³⁾	θ_{JA}	θ_{JC}
QFN-16 (3mmx3mm)	50.....	12 ... °C/W

NOTES:

- 1) Exceeding these ratings may damage the device.
- 2) The maximum allowable power dissipation is a function of the maximum junction temperature T_J (MAX), the junction-to-ambient thermal resistance θ_{JA} , and the ambient temperature T_A. The maximum allowable continuous power dissipation at any ambient temperature is calculated by P_D (MAX) = (T_J (MAX)-T_A)/ θ_{JA} .
- 3) Measured on JESD51-7, 4-layer PCB.

**ELECTRICAL CHARACTERISTICS**

Parameter	Symbol	Condition	Min	Typ	Max	Units
Recommended Operating Conditions						
Supply voltage	V _{DD}		3.0	3.3	3.6	V
Supply current	I _{DD}	From -40°C to +125°C	10.2	11.7	13.8	mA
Operating temperature	T _{op}		-40		125	°C
Applied magnetic field	B		30	60		mT

GENERAL CHARACTERISTICS

VDD = 3.3V, 45mT < B < 100mT, Temp = -40°C to +125°C, unless otherwise noted.

Parameter	Symbol	Condition	Min	Typ	Max	Units
Absolute Output – Serial						
Effective resolution		3 σ deviation of the noise distribution	11.0	11.8	12.8	bit
Noise RMS			0.01	0.02	0.03	deg
Refresh rate			850	980	1100	kHz
Data output length			16		16	bit
Response Time						
Power-up time ⁽⁴⁾					12	ms
Latency ⁽⁴⁾		Constant speed propagation delay	8		10	μ s
Filter cutoff frequency ⁽⁴⁾	Fcutoff			390		Hz
Accuracy						
INL at 25°C		At room temperature over the full field range		0.7		deg
INL between -40°C to +125°C ⁽⁵⁾		Over the full temperature range and field range		1.1		deg
INL at 150°C		over the full field range		1.16		deg
Output Drift						
Temperature induced drift at room temperature ⁽⁵⁾				0.015		deg/°C
Temperature induced variation ⁽⁵⁾		From 25°C to 85°C		0.5		deg
		From 25°C to 125°C		1.0		deg
Magnetic field induced ⁽⁵⁾				0.005		deg/mT
Voltage supply induced ⁽⁵⁾						deg/V
Absolute Output - PWM						
PWM frequency	Fpwm		204	240	264	Hz
PWM resolution			11.0	11.8	12.0	bit
Incremental Output – ABZ						
ABZ update rate				16		MHz
Resolution - edges per turn		Programmable	4		1024	
Pulses per channel per turn	PPT+1	Programmable	1		256	
ABZ hysteresis ⁽⁵⁾	H				0.7	deg
Systematic jitter ⁽⁵⁾		For PPT = 255, between 0 and 100krpm, up to 60mT			13	%
		For PPT = 127, between 0 and 100krpm			7	%
Random jitter (3 σ)		For PPT = 255, between 0 and 100krpm			5.5	%
		For PPT = 127, between 0 and 100krpm			2.8	%
Overall ABZ jitter ⁽⁵⁾		Up to 60mT			0.3	deg

GENERAL CHARACTERISTICS (continued)

VDD = 3.3V, 45mT < B < 100mT, Temp = -40°C to +125°C, unless otherwise noted.

Parameter	Symbol	Condition	Min	Typ	Max	Units
Magnetic Field Detection Thresholds						
Accuracy ⁽⁵⁾				5		mT
Hysteresis ⁽⁵⁾	MagHys			6		mT
Temperature drift ⁽⁵⁾				-600		ppm/°C
Digital I/O						
Input high voltage	V _{IH}		2.5		5.5	V
Input low voltage	V _{IL}		-0.3		0.8	V
Output low voltage ⁽⁵⁾	V _{OL}	I _{OL} = 4mA			0.4	V
Output high voltage ⁽⁵⁾	V _{OH}	I _{OH} = 4mA	2.4			V
Pull-up resistor	R _{PU}		46	66	97	kΩ
Pull-down resistor	R _{PD}		43	55	97	kΩ
Rising edge slew rate ⁽⁴⁾	T _R	CL = 50pF		0.7		V/ns
Falling edge slew rate ⁽⁴⁾	T _F	CL = 50pF		0.7		V/ns

NOTES:

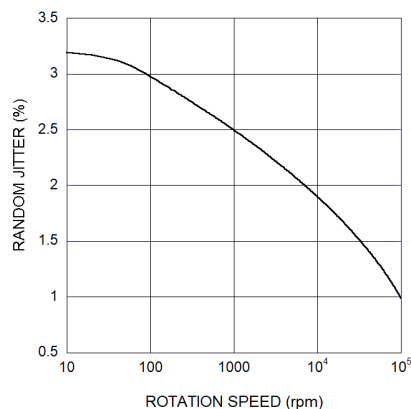
4) Guaranteed by design.

5) Guaranteed by characteristic test.

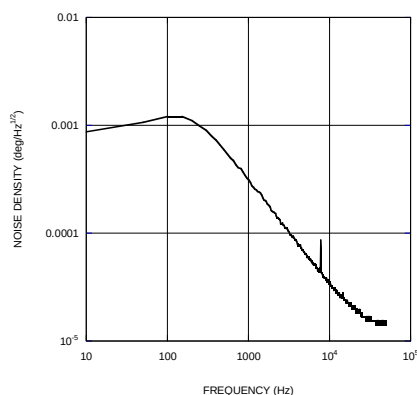
TYPICAL CHARACTERISTICS

VDD = 3.3V, Temp = 25°C, unless otherwise noted.

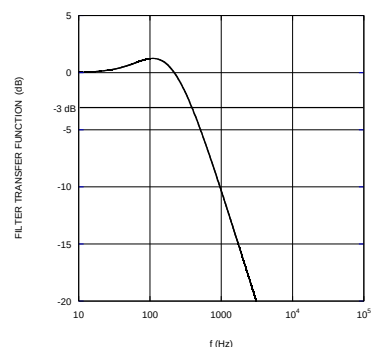
ABZ Jitter at PPT = 255



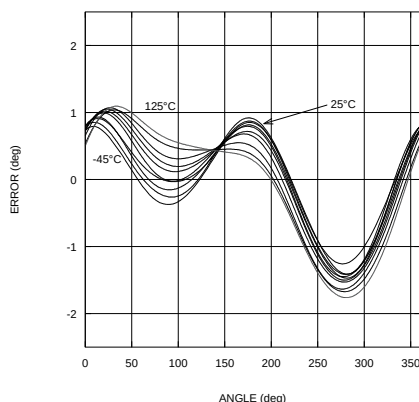
Noise Spectrum at 50mT



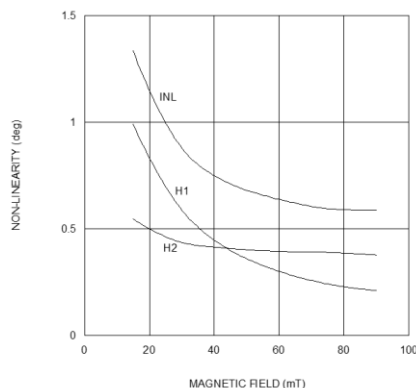
Filter Transfer Function



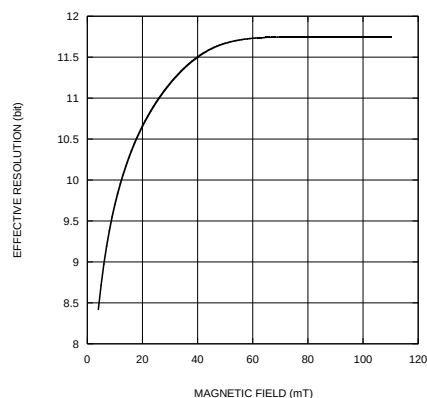
Error Curves at 50mT



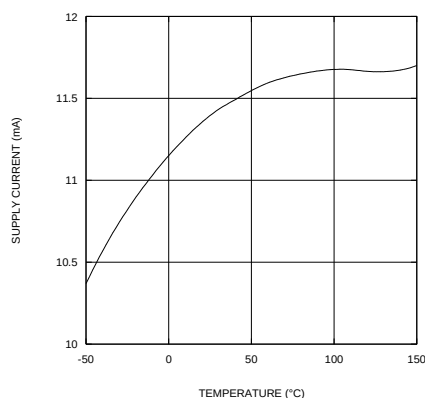
Non-Linearity (INL and Harmonics)



Effective Resolution (3σ)



Current Consumption at VDD = 3.3V



BLOCK DIAGRAM

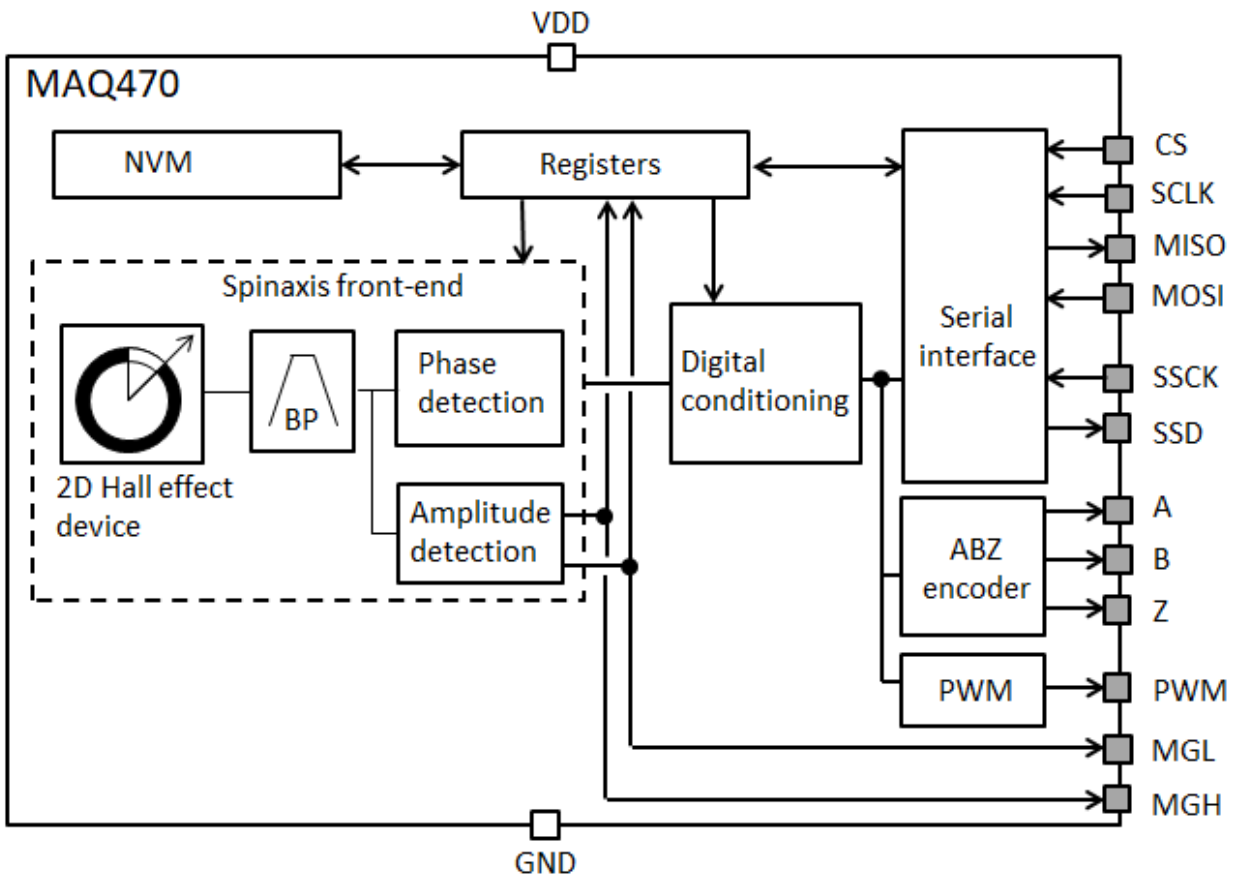


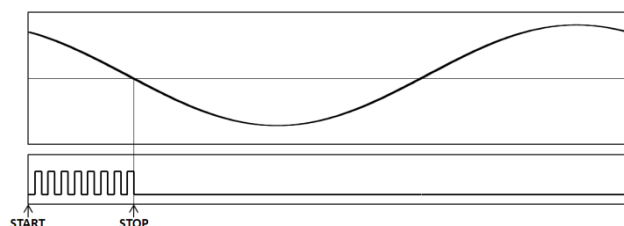
Figure 1: Functional Block Diagram

OPERATION

Sensor Front-End

The magnetic field is detected with integrated Hall devices located in the center of the package. The angle is measured using the *Spinaxis™* method, which digitizes the direction of the field directly without complex arctangent computation or feedback loop-based circuits (interpolators).

The *Spinaxis™* method is based on phase detection and generates a sinusoidal signal with a phase that represents the angle of the magnetic field. The angle is then obtained by a time-to-digital converter, which measures the time between the zero crossing of the sinusoidal signal and the edge of a constant waveform (see Figure 2). The time-to-digital is output from the front-end to the digital conditioning block.



Top: Sine Waveform
Bottom: Clock of Time-to-Digital Converter
Figure 2: Phase Detection Method

The output of the front-end delivers a digital number proportional to the angle of the magnetic field at the rate of 1MHz in a straightforward and open-loop manner.

Digital Filtering

The front-end signal is further treated to achieve the final effective resolution. This treatment does not add any latency in steady conditions. The filter transfer function can be calculated with Equation (1):

$$H(s) = \frac{1 + 2\tau s}{(1 + \tau s)^2} \quad (1)$$

Where τ is the filter time constant related to the cutoff frequency by: $\tau = 0.38/F_{cutoff}$. See the General Characteristics table on page 5 for the value of F_{cutoff} .

Sensor – Magnet Mounting

The sensitive volume of the MAQ470 is confined in a region less than 100µm wide and has multiple integrated Hall devices. This volume is located both horizontally and vertically within 50µm of the center of the QFN package. The sensor detects the angle of the magnetic field projected in a plane parallel to the package's upper surface. This means that the only relevant magnetic field is the in-plane component (X and Y components) in the middle point of the package.

By default, when looking at the top of the package, the angle increases when the magnetic field rotates clockwise. Figure 3 shows the zero angle of the unprogrammed sensor, where the cross indicates the sensitive point. Both the rotation direction and the zero angle can be programmed.

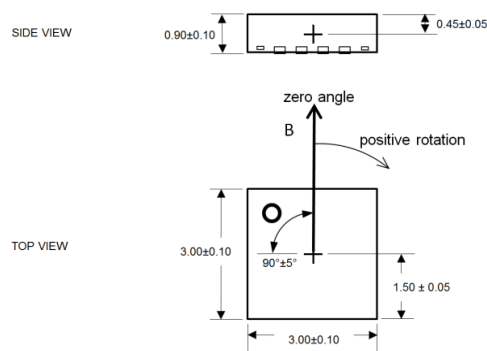
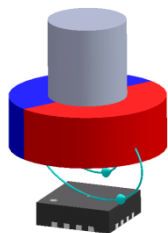
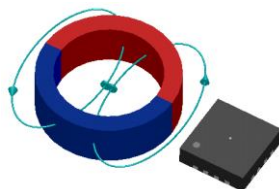


Figure 3: Detection Point and Default Positive Direction

This type of detection provides flexibility for the design of an angular encoder. The sensor only requires the magnetic vector to lie essentially within the sensor plane with a field amplitude of at least 30mT. Note that the MAQ470 can work with fields smaller than 30mT, but the linearity and resolution performance may deviate from the specifications. The most straightforward mounting method is to place the MAQ470 sensor on the rotation axis of a permanent magnet (i.e.: a diametrically magnetized cylinder) (see Figure 4). The recommended magnet is a Neodymium alloy (N35) cylinder with dimensions Ø5x3mm inserted into an aluminum shaft with a 1.5mm air gap between the magnet and the sensor (surface of package). For good linearity, the sensor is positioned with a precision of 0.5mm.

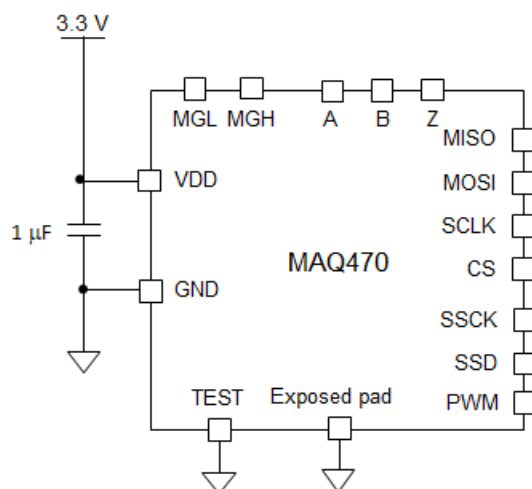

Figure 4: End-of-Shaft Mounting

If the end-of-shaft position is not available, the sensor can be positioned away from the rotation axis of a cylinder or ring magnet (see Figure 5). In this case, the magnetic field angle is no longer directly proportional to the mechanical angle. The MAQ470 can be adjusted to compensate for this effect and recover the linear relation between the mechanical angle and the sensor output. With multiple pole pair magnets, the MAQ470 indicates multiple rotations for each mechanical turn.


Figure 5: Side-Shaft Mounting

Electrical Mounting and Power Supply Decoupling

It is recommended to place a 1 μ F decoupling capacitor close to the sensor with a low impedance path to GND (see Figure 6).


Figure 6: Connection for Supply Decoupling

In general, the MagAlpha works well with or without the exposed pad connected. For optimum conditions (electrically, thermally, and mechanically), it is recommended that the exposed pad be connected to ground.

Serial Interface

The sensor supports the SPI serial interface for angle reading and register programming. Alternatively, the SSI bus can be used for angle reading (programming through SSI is not supported).

Data length is 16 bit. For checking the integrity of the data received (angle or register content) the master shall send a 17th clock count and receive a parity bit.

SPI

SPI is a four-wire, synchronous, serial communication interface. The MagAlpha supports SPI Mode 3 and Mode 0 (see Table 1 and Table 2). The SPI Mode (0 or 3) is detected automatically by the sensor and therefore does not require any action from the user. The maximum clock rate supported on SPI is 25MHz. There is no minimum clock rate. Note that real-life data rates depend on the PCB layout quality and signal trace length. See Figure 7 and Table 3 for SPI timing.

All commands to the MagAlpha (whether for writing or reading register content) must be transferred through the SPI MOSI pin and must be 16-bit long.

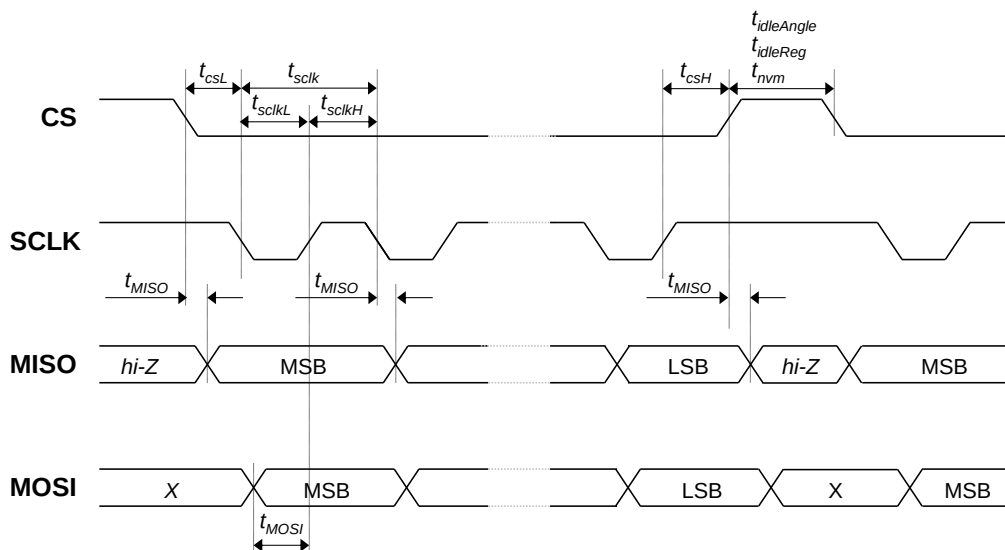
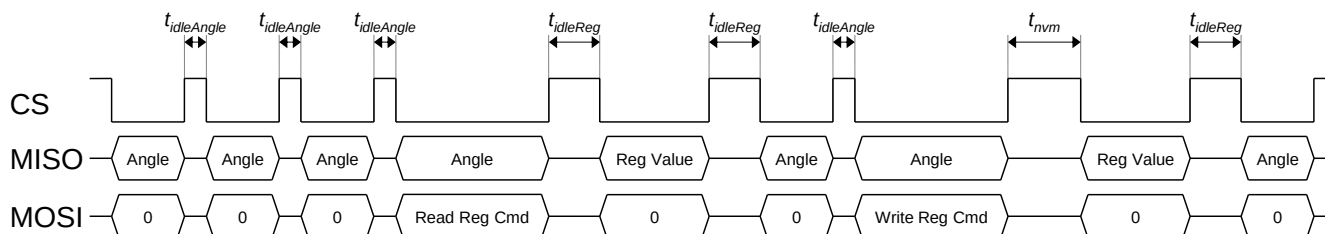
See the SPI Communication section on page 13 for details.

Table 1: SPI Specification

	Mode 0	Mode 3
SCLK idle state	Low	High
Data capture	On SCLK rising edge	
Data transmission	On SCLK falling edge	
CS idle state	High	
Data order	MSB first	

Table 2: SPI Standard

	Mode 0	Mode 3
CPOL	0	1
CPHA	0	1
Data Order (DORD)	0 (MSB first)	


Figure 7: SPI Timing Diagram

Figure 8: Minimum Idle Time
Table 3: SPI Timing

Parameter ⁽⁶⁾	Description	Min	Max	Unit
$t_{idleAngle}$	Idle time between two subsequent angle transmissions	150		ns
$t_{idleReg}$	Idle time before and after a register readout	750		ns
t_{nvM}	Idle time between a write command and a register readout (delay necessary for non-volatile memory update)	20		ms
t_{csL}	Time between CS falling edge and SCLK falling edge	80		ns
t_{sklk}	SCLK period	40		ns
t_{sklkL}	Low level of SCLK signal	20		ns
t_{sklkH}	High level of SCLK signal	20		ns
t_{csH}	Time between SCLK rising edge and CS rising edge	25		ns
t_{MISO}	SCLK setting edge to data output valid		15	ns
t_{MOSI}	Data input valid to SCLK reading edge	15		ns

NOTE:

6) All values are guaranteed by design.

SPI Communication

The sensor supports three types of SPI operation:

- Read angle
- Read configuration register
- Write configuration register

Each operation has a specific frame structure described below.

SPI Read Angle

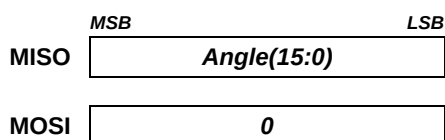
Every 1μs, new data is transferred into the output buffer. The master device triggers the reading by pulling CS low.

When a trigger event is detected, the data remains in the output buffer until the CS signal is de-asserted (see Table 4).

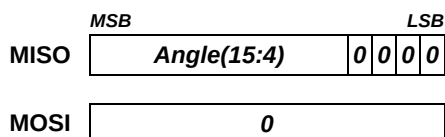
Table 4: Sensor Data Timing

Event	Action
CS falling edge	Start reading and freeze output buffer
CS rising edge	Release of the output buffer

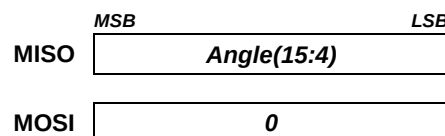
See Figure 9 for a diagram of a full SPI angle reading. See Figure 10 for a partial SPI angle reading. A full angle reading requires 16 clock pulses. The sensor MISO line returns:



The MagAlpha family has sensors with different features and levels of resolution. See the data output length section in the General Characteristics table on page 5 for the number of useful bits delivered at the serial output. If the data length is smaller than 16, the rest of the bits sent are zeros. For example, a data output length of 12 bits means that the serial output delivers a 12-bit angle value with four bits of zeros padded at the end (MISO state remains zero). If the master sends 16 clock counts, the MagAlpha replies with:



Angle reading can be therefore optimized, without any loss of information, by reducing the number of clock counts. In the case of a 12-bit data output length, only 12 clock counts are required to get the full sensor resolution.



If less resolution is needed, the angle can be read by sending even fewer clock counts (since the MSB is first).

In case of fast reading, the MagAlpha continues sending the same data until the data is refreshed. See the refresh rate section in the General Characteristics table on page 5.

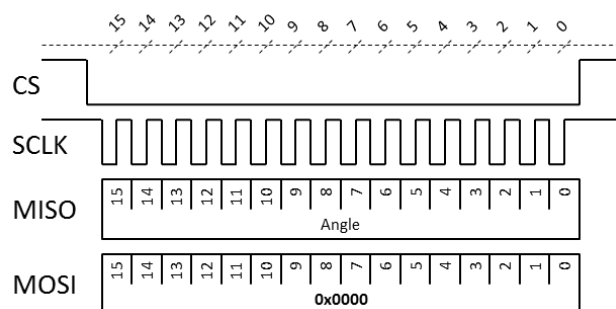


Figure 9: Diagram of a Full 16-Bit SPI Angle Reading

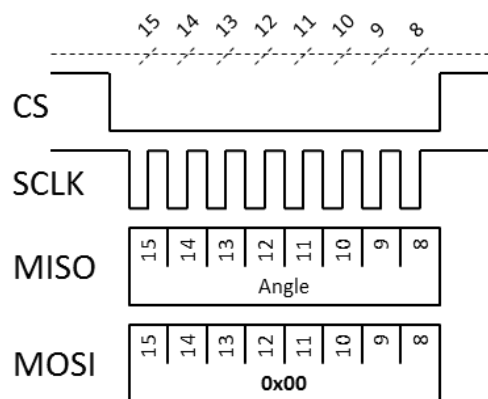
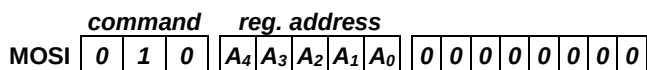
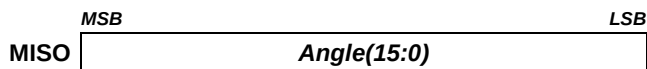


Figure 10: Diagram of a Partial 8-Bit SPI Angle Reading

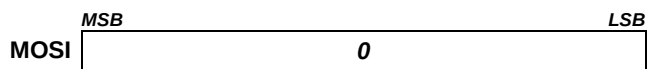
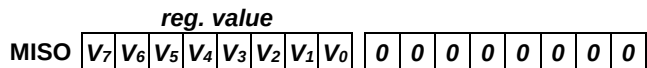
SPI Read Register

A read register operation is constituted of two 16-bit frames. The first frame sends a read request, which contains the 3-bit read command (010) followed by the 5-bit register address. The last 8 bits of the frame must be all set to 0. The second frame returns the 8-bit register value (MSB byte).

First 16-bit SPI frame (read request):

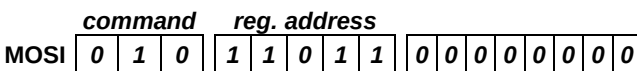
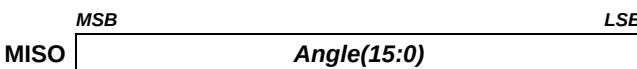


Second 16-bit SPI frame (response):

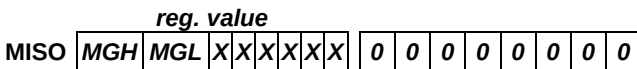


See Figure 11 for a complete transmission overview.

For example, to get the value of the magnetic level high and low flags (MGH and MGL), read register 27 (bit 6, bit 7) by sending the following first frame:



In the second frame, the MagAlpha replies:



See Figure 12 for a complete example overview.

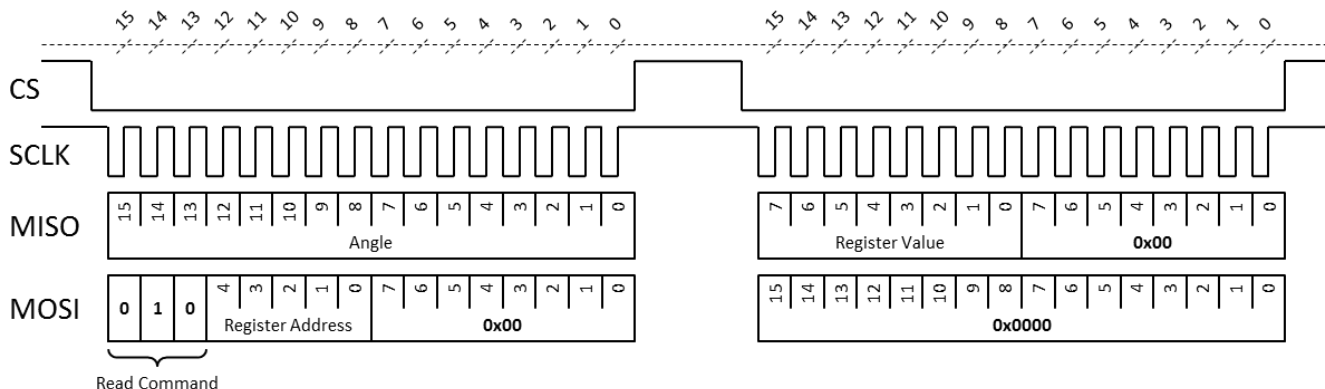


Figure 11: Two 16-Bit Frames Read Register Operation

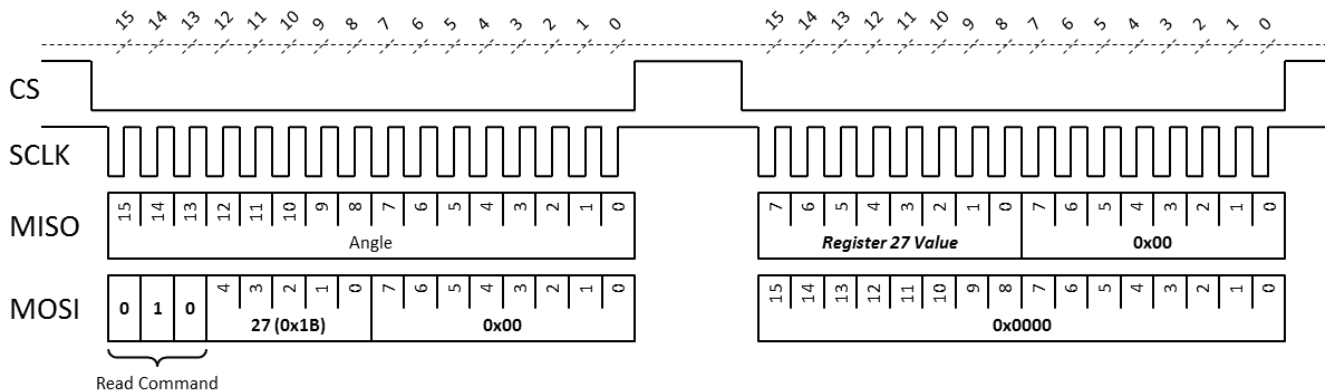


Figure 12: Example Read Magnetic Level Flags High and Low (MGH, MGL) on Register 27, Bit 7-6

SPI Write Register

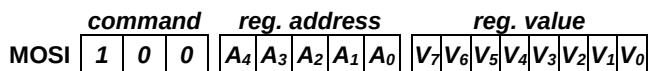
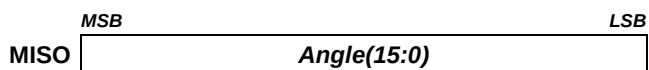
Table 7 shows the programmable 8-bit registers. Data written to these registers are stored in the on-chip non-volatile memory and reloaded at power-on automatically. The factory default register values are shown in Table 8.

A write register operation is constituted of two 16-bit frames. The first frame sends a write request, which contains the 3-bit write command (100) followed by the 5-bit register address and the 8-bit value (MSB first). The second frame returns the newly written register value (acknowledge).

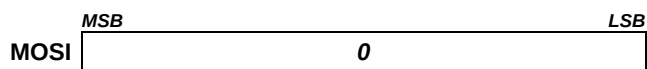
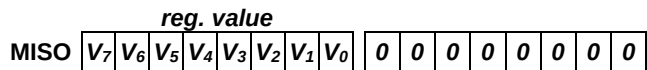
The on-chip memory is guaranteed to endure 1,000 write cycles at 25°C.

It is critical to wait 20ms between the first and the second frame. This is the time taken to write the non-volatile memory. Failure to implement this wait period results in the register's previous value being read. Note that this delay is only required after a write request. A read register request and read angle do not require this wait time.

The first 16-bit SPI frame (write request) is:

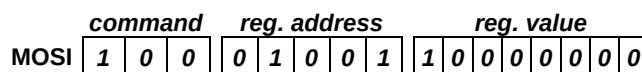
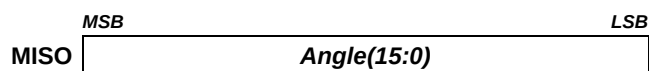


The second 16-bit SPI frame (response) is:

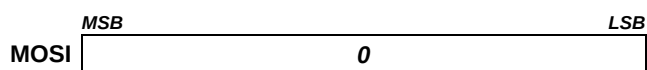
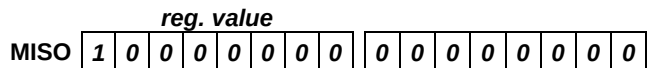


The read-back register content can be used to verify the register programming. See Figure 13 for a complete transmission overview.

For example, to set the value of the output rotation direction (RD) to counterclockwise (high). Write register 9 by sending the following first frame:



Send the second frame after a 20ms wait time. If the register is written correctly, the reply is:



See Figure 14 for a complete example.

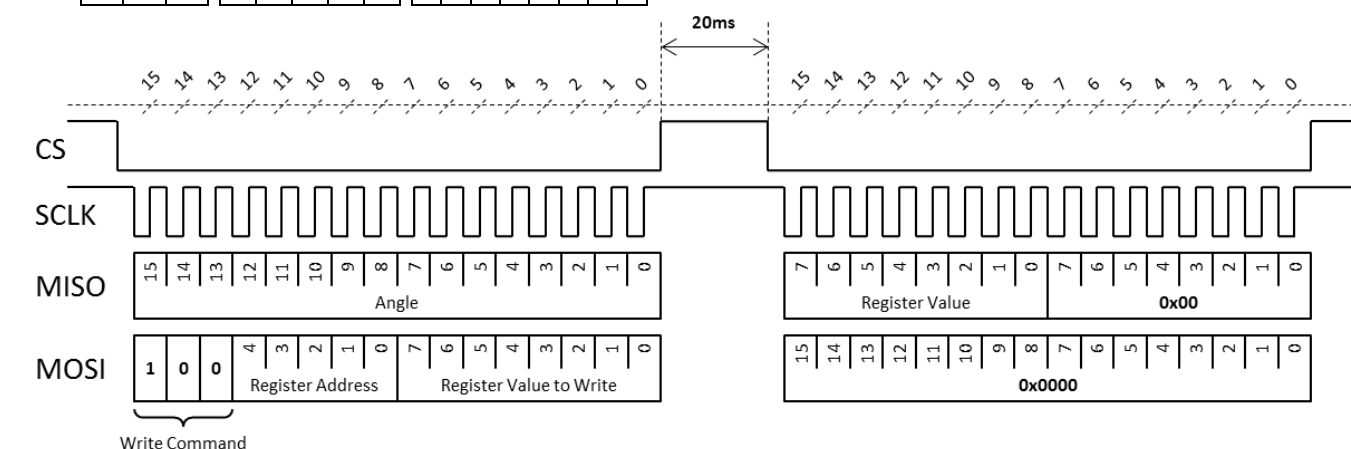


Figure 13: Overview of Two 16-Bit Frames Write Register Operation

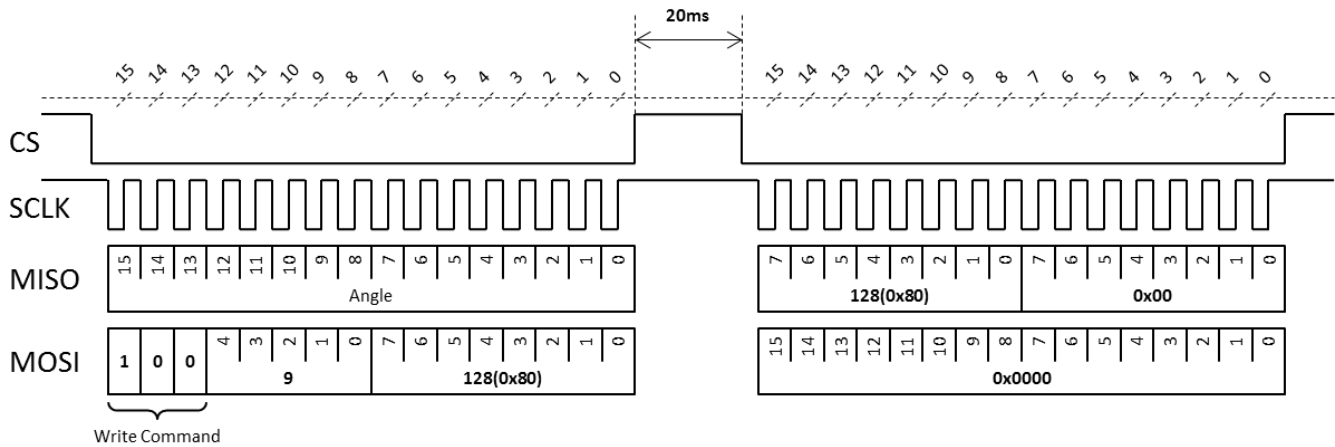


Figure 14: Example Write Output Rotation Direction (RD) to Counterclockwise (High), on Register 9, Bit 7

SSI

The SSI is a 2-wire synchronous serial interface for data reading only. The sensor operates as a slave to the external SSI master and only supports angle reading. It is not possible to read or write registers via the SSI.

SSI Communication

Unlike SPI, the sensor SSI only supports angle reading operation. It is not possible to read or write registers using the SSI. Figure 15 and Table 5 show the SSI timing communication.

The SSI implemented in this sensor is different from the standard SSI. For this reason, it may not work with regular SSI devices.

This sensor uses an SSI with a low SSCK idle state instead of the high SSCK idle state used in the standard protocol. This sensor also requires a dummy rising edge on the SSCK signal at the beginning of the SSI frame, meanwhile the standard SSI does not have this requirement.

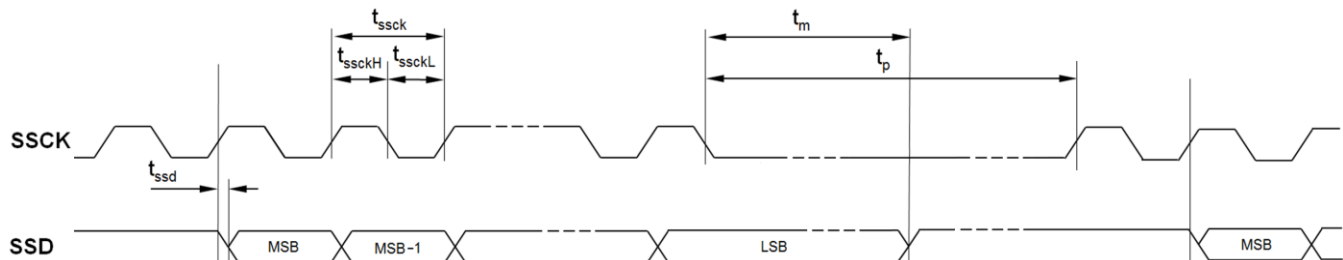


Figure 15: SSI Timing

Table 5: SSI Timing

Parameter	Description	Min	Max	Units
t_{ssd}			15	ns
t_{ssck}	SSCK period	0.2	16	μ s
t_{ssckL}	Low level of SSCK signal	0.1	8	μ s
t_{ssckH}	High level of SSCK signal	0.1	8	μ s
t_m	Transfer timeout (monoflop time)	25		μ s
t_p	Dead time: SSCK high time for next data reading	40		μ s

SSI Read Angle

The bit order of the transmitted data is MSB first and LSB last. Every 1 μ s, new data is transferred into the output buffer. The master

device triggers the reading by driving SSCK high. A full reading requires up to 17 clock counts (see Figure 16).

The first clock is a dummy clock to start the transmission. The data length is up to 16 bits long. See the data output length section in the General Characteristics table on page 5 for the number of useful bits delivered at the serial output.

The first data MSB is transmitted on the second clock count. If the data length is less than 16, the 16-bit output word is completed by zeros. Therefore, the reading can also be performed with fewer than 16 clock counts. For example,

for a part with a 12-bit data length, it is only necessary to send the first dummy clock to start the transmission + 12 clocks to read the angle data.

When a trigger event is detected, the data remains in the output buffer until the clock falling edge for the LSB bit 0 and the transfer timeout time has passed (see Table 6).

Table 6: Sensor Data Timing

Trigger Event	Release of the Output Buffer
First SSCK pulse rising edge	SSCK falling edge + time out t_m (Fig 15)

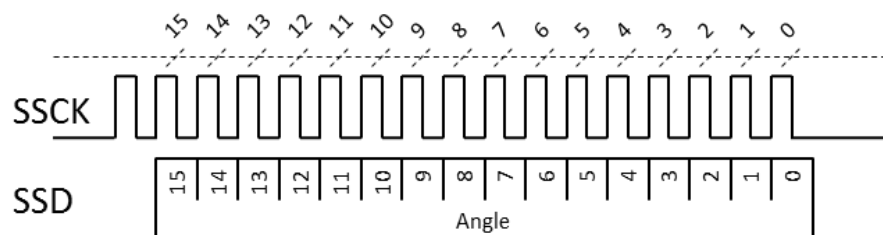


Figure 16: Diagram of a Full 16-Bit SSI Angle Reading (with First Dummy Clock)

For consecutive angle readings, see the timing in Figure 17.

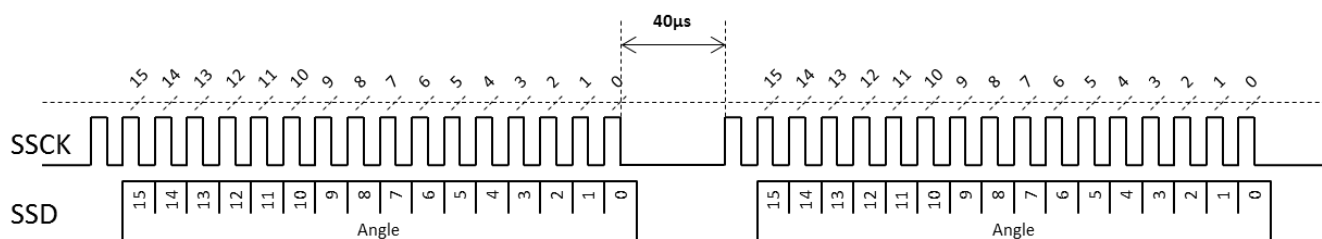


Figure 17: Diagram of Two Consecutive 16-Bit SSI Angle Reading with the Required Dead Time between the Frames

Parity bit

The parity bit, or check bit, is added to the output string to ensure that the total number of 1's in the string is even. It is used as error detecting code for angle or register reading. The MagAlpha transmits the parity bit at the 17th clock edge. See table 7 and figure 18

Table 7: Example of Parity bit

16-bits output	Number of bits set to "1"	Output with the parity bit
0000000000000000	0	0000000000000000
1000110001100010	6	1000110001100010
0101110100000000	5	0101110100000001

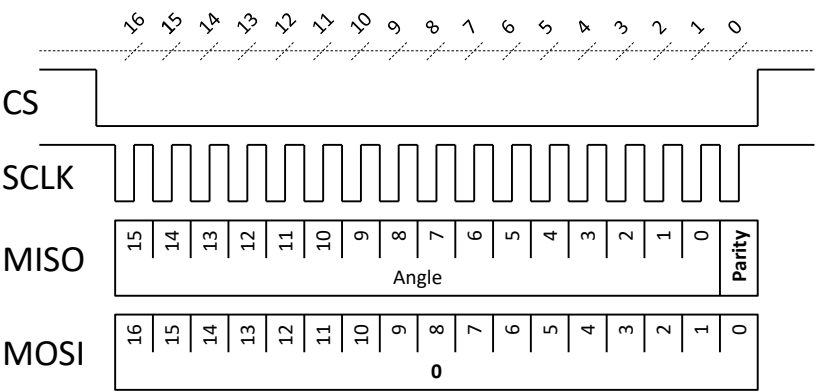


Figure 18: SPI Angle reading with parity bit

REGISTER MAP

Table 8: Register Map

No	Hex	Bin	Bit 7 MSB	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0 LSB
0	0x0	00000	Z(7:0)							
1	0x1	00001	Z(15:8)							
2	0x2	00010	BCT(7:0)							
3	0x3	00011	-	-	-	-	-	-	ETY	ETX
4	0x4	00100	PPT(1:0)		ILIP(3:0)				-	-
5	0x5	00101	-	-	PPT(7:2)					
6	0x6	00110	MGLT(2:0)			MGHT(2:0)			-	-
9	0x9	01001	RD	-	-	-	-	-	-	-
27	0x1B	11011	MGH	MGL	MIR(3:0)				-	-

Table 9: Factory Default Values

No	Hex	Bin	Bit 7 MSB	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0 LSB
0	0x0	00000	0	0	0	0	0	0	0	0
1	0x1	00001	0	0	0	0	0	0	0	0
2	0x2	00010	0	0	0	0	0	0	0	0
3	0x3	00011	0	0	0	0	0	0	0	0
4	0x4	00100	1	1	0	0	0	0	0	0
5	0x5	00101	0	0	1	1	1	1	1	1
6	0x6	00110	0	0	0	1	1	1	0	0
9	0x9	01001	0	0	0	0	0	0	0	0

Table 10: Programming Parameters

Parameters	Symbol	Number of Bits	Description	See Table
Zero Setting	Z	16	Set the zero position	11
Bias Current Trimming	BCT	8	For side-shaft configuration: reduce the bias current of the X or Y Hall device	14
Enable Trimming X	ETX	1	Biased current trimmed in the X direction Hall device	15
Enable Trimming Y	ETY	1	Biased current trimmed in the Y direction Hall device	15
Pulses Per Turn	PPT	8	Number of pulses per turn of the ABZ output	18
Index Length / Index Position	ILIP	4	Parametrization of the ABZ index pulse	Fig 26
Magnetic Field High Threshold	MGHT	3	Sets the field strength high threshold	17
Magnetic Field Low Threshold	MGLT	3	Sets the field strength low threshold	17
Rotation Direction	RD	1	Determines the sensor positive direction	13
Magnetic field In Range	MIR	3	Indicates that the measured field level is correct	20

REGISTER SETTINGS

Zero Setting

The zero position of the MagAlpha (a_0) can be programmed with 16 bits of resolution. The angle streamed out by the MagAlpha (a_{out}) is given by Equation (2):

$$a_{out} = a_{raw} - a_0 \quad (2)$$

Where a_{raw} is the raw angle provided by the MagAlpha front end.

The parameter Z(15:0), which is zero by default, is the complementary angle of the zero setting. In decimals, it can be written as shown in Equation (3):

$$a_0 = 2^{16} - Z(15:0) \quad (3)$$

Table 11 shows the zero setting parameter.

Table 11: Zero Setting Parameter

Z(15:0)	Zero pos. a_0 (16 bit dec)	Zero pos. a_0 (deg)
0	65536	360.000
1	65535	359.995
2	65534	359.989
...	...	...
65534	2	0.011
65535	1	0.005

Example

To set the zero position to 20 degrees, the Z(15:0) parameter must be equal to the complementary angle and can be calculated with Equation (4):

$$Z(15:0) = 2^{16} - \frac{20\text{deg}}{360\text{deg}} 2^{16} = 61895 \quad (4)$$

In binary, it is written as 1111 0001 1100 0111.

Table 12 shows the content of the registers 0 and 1.

Table 12: Register 0 and 1 Content

Reg	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0	1	1	0	0	0	1	1	1
1	1	1	1	1	0	0	0	1

Rotation Direction

By default, when looking at the top of the package, the angle increases when the magnetic field rotates clockwise (CW) (see Figure 19 and Table 13).

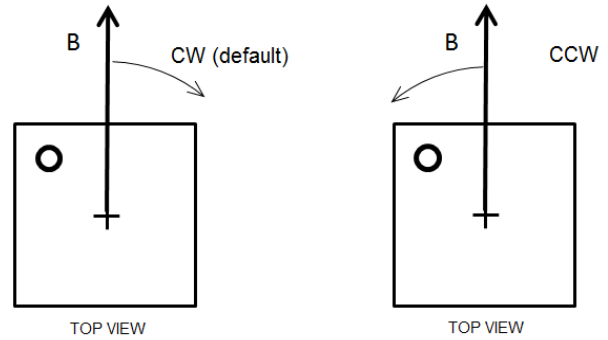


Figure 19: Positive Rotation Direction of the Magnetic Field

Table 13: Rotation Direction Parameter

RD	Positive Direction
0	Clockwise (CW)
1	Counterclockwise (CCW)

BCT Settings (Bias Current Trimming)

Side Shaft

When the MAQ470 is mounted on the side of the magnet, the relation between the field angle and the mechanical angle is no longer directly linear. This effect is related to the fact that the tangential magnetic field is usually smaller than the radial field. Define the field ratio k with Equation (5):

$$k = B_{rad} / B_{tan} \quad (5)$$

Where B_{rad} and B_{tan} are the maximum radial and tangential magnetic fields (see Figure 20).

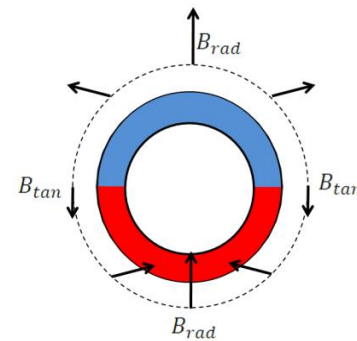


Figure 20: Side-Shaft Field

The ratio k depends on the magnet geometry and the distance to the sensor. Having a k ratio different than 1 results in the sensor output response not being linear with respect to the mechanical angle. Note that the error curve has the shape of a double sinewave (see Figure 22). E is the amplitude of this error.

The X-axis or the Y-axis bias current can be reduced by programming in order to recover an equal Hall signal for all angles and therefore suppress the error. The parameter ETX and ETY controls the direction in which sensitivity is reduced. The current reduction is set by the parameter bias current trimming BCT(7:0), which is an integer from 0 to 255.

In side-shaft configuration (i.e.: the sensor center is located beyond the magnet outer diameter), k is greater than 1. For optimum compensation, the sensitivity of the radial axis should be reduced by setting the BCT parameter as shown in Equation (6):

$$BCT(7:0) = 258 \left(1 - \frac{1}{k} \right) \quad (6)$$

The graph in Figure 21 shows the optimum BCT value for a particular k ratio.

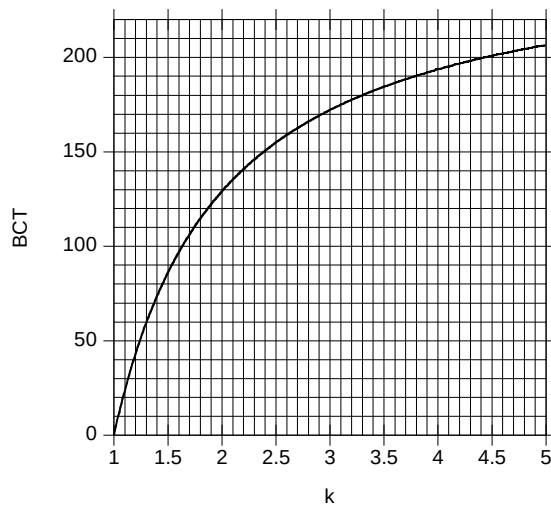


Figure 21: Relation between the k Ratio and the Optimum BCT to Recover Linearity

Table 14 shows some typical BCT values.

Table 14: Example of BCT Settings

E (deg)	Magnet Ratio k	BCT(7:0)
0	1.0	0
11.5	1.5	86
19.5	2.0	129
25.4	2.5	155
30.0	3.0	172
33.7	3.5	184
36.9	4.0	194
39.5	4.5	201
41.8	5.0	207

Determining k with the MagAlpha

It is possible to deduce the k ratio from the error curve obtained with the default BCT setting (BCT = 0). For this purpose, rotate the magnet over one revolution and record the MagAlpha output. Then plot the error curve (the MagAlpha output minus the real mechanical position vs the real mechanical position) and extract two parameters: the maximum error E and the position of this maximum with respect to a zero crossing a_m (see Figure 22). k can be calculated with Equation (7):

$$k = \frac{\tan(E + a_m)}{\tan(a_m)} \quad (7)$$

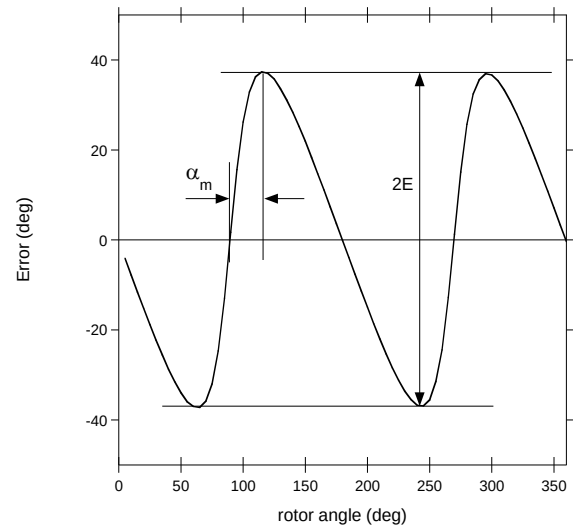


Figure 22: Error Curve in Side-Shaft Configuration with BCT = 0

Some examples are given in Table 14. Alternatively, the k parameter can be obtained from the graph of Figure 23.

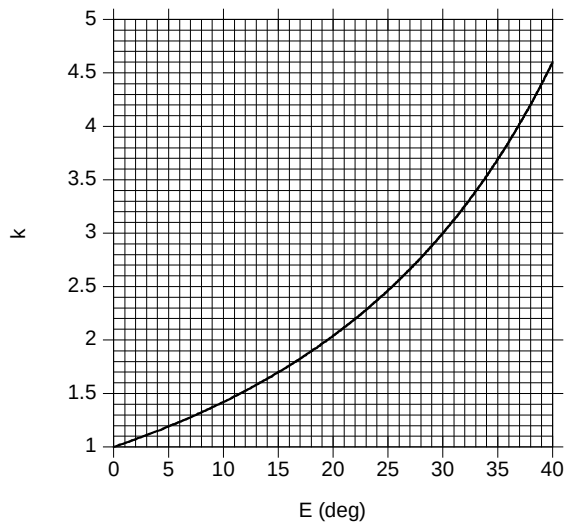


Figure 23: Relation between the Error Measured with BCT = 0 and the Magnet Ratio k

Sensor Orientation

From the dot marked on the package, it is possible to know whether the radial field is aligned with the sensor coordinate X or Y (see Figure 24).

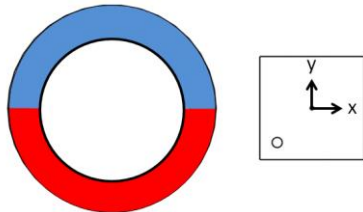


Figure 24: Package Top View with X and Y Axes

Determine which axis needs to be reduced (see the qualitative field distribution around a ring in Figure 20). For instance, with the arrangement depicted in Figure 24, the field along the sensor Y direction is tangential and weaker. The X-axis should be reduced (ETX = 1 and ETY = 0). Note that if both ETX and ETY are set to 1, the current bias is reduced in both directions the same way (i.e.: without side-shaft correction) (see Table 15).

Table 15: Trimming Direction Parameters

ETX	Enable Trimming of the X-Axis
0	Disabled
1	Enabled
ETY	Enable Trimming of the Y-Axis
0	Disabled
1	Enabled

Magnetic Field Thresholds

The magnetic flags (MGL and MGH) indicate that the magnetic field at the sensor position is out a range defined by the lower (MGLT) and upper magnetic field thresholds (MGHT) (see Figure 25).

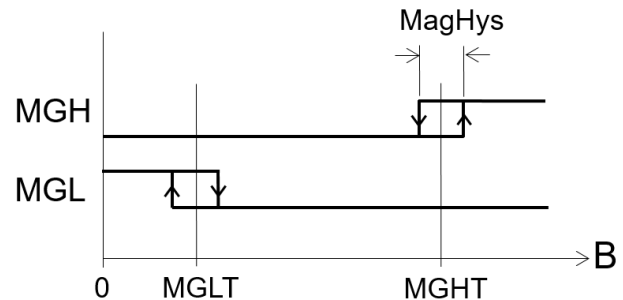


Figure 25: MGH and MGL Signals as a Function of the Field Strength

MagHys, the typical hysteresis on the signals MGH and MGL is 6mT. The MGLT and MGHT thresholds are coded on three bits and stored in register 6 (see Table 16).

Table 16: Register 6

Register 6							
Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
MGLT			MGHT			-	-

The 3-bit values of MGLT and MGHT correspond to the magnetic field (see Table 17).

Table 17: MGLT and MGHT: Binary to mT Relation

MGLT or MGHT ⁽⁸⁾	Field threshold in mT ⁽⁷⁾	
	From low to high magnetic field	From high to low magnetic field
000	26	20
001	41	35
010	56	50
011	70	64
100	84	78
101	98	92
110	112	106
111	126	120

NOTES:

7) Valid for VDD=3.3V. If different then field threshold is scaled by the factor VDD/3.3V.

8) MGLT can have a larger value than MGHT.

The alarm flags MGL and MGH are available to be read in register 27 (bit 6, bit 7), and their logic state is also given at the digital output pins 11 and 16.

To read the MGL and MGH flags via the SPI, send the 8-bit command write to register 27:

command	reg. address	MSB	value	LSB
0 1 0	1 1 0 1 1	0 0 0 0 0 0 0 0		

The MAQ470 answers with the register 27 content in the next transmission:

Register 27 [7:0]							
MGH	MGL	x	x	MG1L	MG2L	x	x

The logic state of the MGL and MGH flags has no effect on the angle output.

MGL Application Note

Pulses with a duration of about 1.3µs to 1.5µs appear randomly in the MGL signal. They appear on both the pin and register values (Register 27, bit 6).

These pulses appear around angle values of 44, 138, 224, and 318 degrees (sensor output) or in an interval of ±1.5 degrees around these values. These pulses have an amplitude of 3.3V (VDD). The minimum interval between two pulses is 100µs.

MGL Workarounds

1. Invert the MGH signal to replace MGL. The MGL and MGH magnetic thresholds only differ by a small hysteresis (see Table 17 on page 21). An inverted MGH signal can be used to replace the MGL output in the application.
2. Read the MGL signal level twice. Using two readings, which must be between 2µs and 100µs apart, allows the user to distinguish erroneous from real transitions. Table 18 shows examples of different cases.
3. Read register 27 with the SPI and compute a corrected MGL value using MG1L and MG2L. The corrected MGL signal = not (MG1L OR MG2L). This means that the corrected MGL must be set to 1 only when both MG1L and MG2L are equal to 0. See the C implementation below:

```
correctedMGL = !(MG1L | MG2L)
```

Table 18: MGL Multiple Reading Workaround

	MGL First Reading	MGL Second Reading (e.g. 20µs After the First Reading)	True MGL Value
Case 1	0	Second reading is not needed	0
Case 2	1	1	1
Case 3	1	0	0

ABZ Incremental Encoder Output

The MAQ470 ABZ output emulates a 10-bit incremental encoder (such as an optical encoder) providing logic pulses in quadrature (see Figure 26). Compared to signal A, signal B is shifted by a quarter of the pulse period. Over one revolution, signal A pulses *N* times, where *N* is programmable from 1 to 256 pulses per revolution. The number of pulses per channel per revolution is programmed by setting the parameter PPT, which consists of eight bits split between registers 0x4 and 0x5 (see Table 8). The factory default value is 256. Table 19 describes how to program PPT(7:0) to set the required resolution.

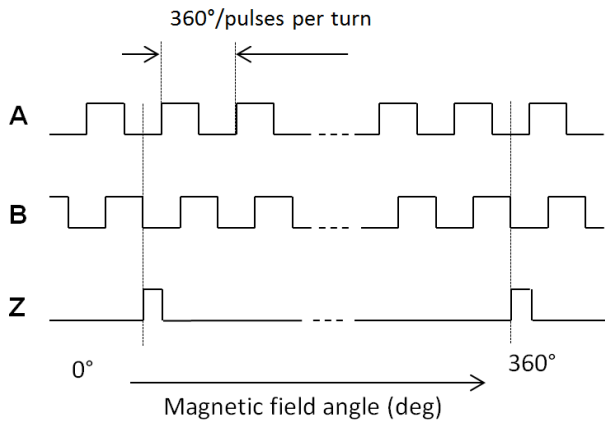
Table 19: PPT

PPT(7:0)	Pulses per Turn	Edges per Turn	
00000000	1	4	MIN
00000001	2	8	
00000010	3	12	
00000011	4	16	
...	...	...	...
11111100	253	1012	
11111101	254	1016	
11111110	255	1020	
11111111	256	1024	MAX

For example, to set 120 pulses per revolution (i.e.: 480 edges), set PPT to 120 - 1 = 119. In binary: 01110111. Thus the registers 4 and 5 must be set as shown in Table 20.

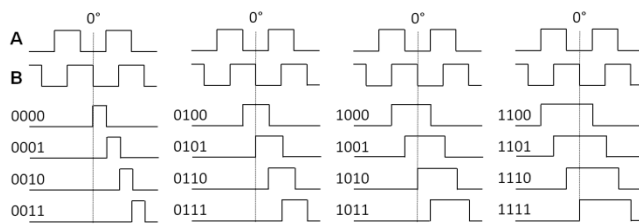
Table 20: Example PPT Setting for 120 Pulses

	B7	B6	B5	B4	B3	B2	B1	B0
R4	1	1	0	0	0	0	0	0
R5	0	0	0	1	1	1	0	1


Figure 26: Timing of the ABZ Output

Signal Z (zero or index) raises only once per turn at the zero-angle position.

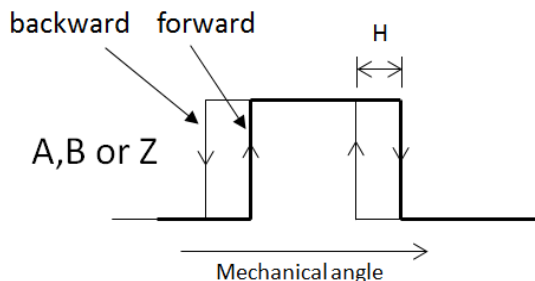
The position and length of the Z pulse is programmable via bits ILIP(3:0) in register 0x4 (see Figure 27).


Figure 27: ILIP Parameter Effect on Index Shape

By default, the ILIP parameter is 0000. The index rising edge is aligned with the channel B falling edge. The index length is half the A or B pulse length.

ABZ Hysteresis

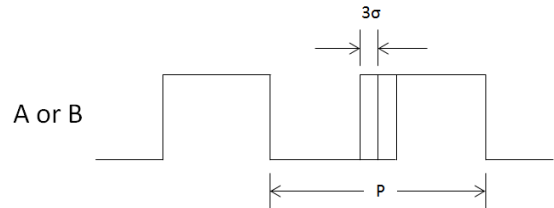
A hysteresis larger than the output noise is introduced on the ABZ output to avoid any spurious transitions (see Figure 28).


Figure 28: Hysteresis of the Incremental Output

ABZ Jitter

The ABZ state is updated at a frequency of 16MHz, enabling accurate operation up to a very high rpm (above 10^5 rpm).

The jitter characterizes how far a particular ABZ edge can occur at an angular position different from the ideal position (see Figure 29).


Figure 29: ABZ Jitter

The measurable jitter is composed by a systematic jitter (i.e. always the same deviation at a given angle) and a random jitter.

The random jitter reflects the sensor noise. Therefore, the edge distribution is the same as the SPI output noise. Like the sensor resolution, it is defined as the 3σ width of this distribution.

In fact, the random jitter is a function of the rotation speed. At a lower speed, the random jitter is smaller than the sensor noise.

This is a consequence of the fact that the probability of measuring an edge at a certain distance from the ideal position depends on the number of ABZ updates at this position.

The minimum field for ABZ reading is 30mT.

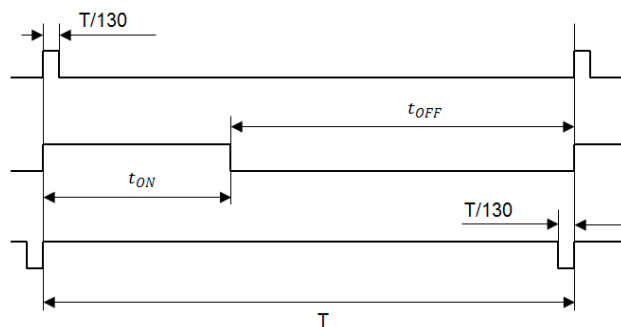
PWM Absolute Output

This output provides a logic signal with a duty cycle proportional to the angle of the magnetic field. The PWM frequency is indicated in the General Characteristics table on page 5. The duty cycle is bounded by a minimum value (1/130 of the period) and a maximum value (129/130 of the period) (see Figure 30), so the duty cycle varies from 1/130 to 129/130 with a resolution of 12 bits. The angle can be retrieved by measuring the on time. Since the absolute PWM frequency can vary from chip to chip or with the temperature, accurate angle detection requires the measurement of the duty cycle (i.e.: the measurement of both the on time (t_{on}) and the off time (t_{off})).

The angle can be calculated with Equation (8):

$$angle(in\ deg) = 360 \frac{1}{128} \left(130 \frac{t_{ON}}{t_{ON} + t_{OFF}} - 1 \right) \quad (8)$$

Figure 30 shows one period of the PWM signal. The period T is 1/F_{pwm}, where F_{pwm} is the PWM frequency indicated in the General Characteristics table.



Top Signal: 0°

Bottom Signal: Full Scale (i.e.: 360°(1-1/4096))

Figure 30: PWM Output Timing

Diagnostic Features

The following feature can be used to determine correct functional operation of the sensor.

- 1) Parity bit on the angle (see description of the parity bit on page 16)
- 2) Magnetic Field in Range via MIR(3:0)

Magnetic Field In Range

The bits MIR(3:0) in register 27 can be used to verify that the magnetic field is between the thresholds set by MGLT(2:0) and MGHT(2:0) in register 6. The value of MIR(3:0) will be 0011 when the field is between these thresholds. This also indicates that the Hall sensor front end is functioning correctly and acquiring angle samples.

For example: Assuming MGLT(2:0) is left at the default value of 00 representing 15mT, and the MGHT(2:0) is left at 111 representing 126mT, then if the field strength is between these values, the MIR(3:0) value will be 0011.

For the above default threshold settings, values of MIR(3:0) can be decoded as shown in table 21.

Table 21: MIR(3:0) logic states

MIR(3:0)	Conditions MGLT(2:0) at default of 15mT, MGHT(2:0) at default of 126mT
0011	Field in range and Hall sensor array operational
1111	Field above MAGH and MAGL threshold – magnet too close to sensor
0000	Field below MAGH and MAGL threshold – magnet too far away / missing
0001	Invalid state : Hall array sensor functional error
0010	Invalid state : Hall array sensor functional error
0100	Invalid state : Hall array sensor functional error
1000	Invalid state : Hall array sensor functional error
1001	Invalid state : Hall array sensor functional error
1010	Invalid state : Hall array sensor functional error
1011	Invalid state : Hall array sensor functional error
1100	Invalid state : Hall array sensor functional error
1101	Invalid state : Hall array sensor functional error

TYPICAL APPLICATION CIRCUITS

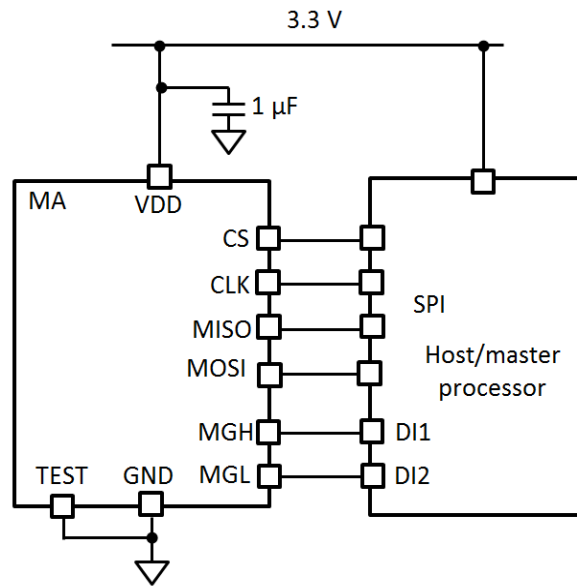


Figure 31: Typical Configurations Using SPI Interface and MGH/MGL Signals

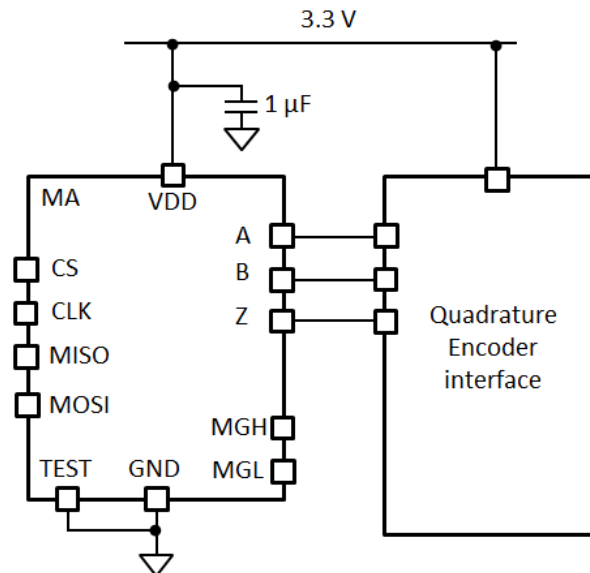
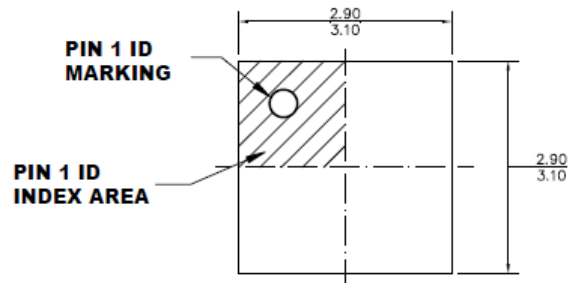


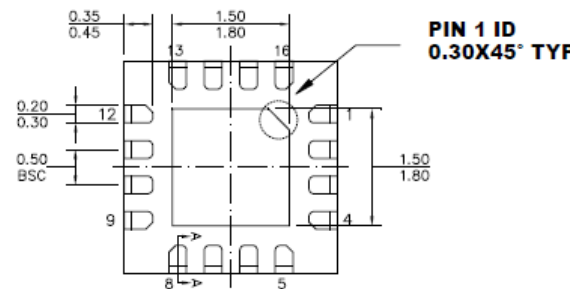
Figure 32: Typical Configuration Using ABZ Interface

PACKAGE INFORMATION

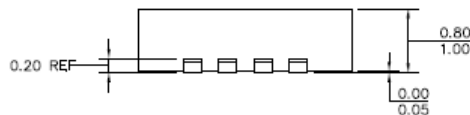
QFN-16 (3mmx3mm)



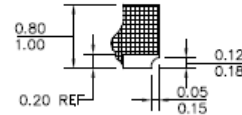
TOP VIEW



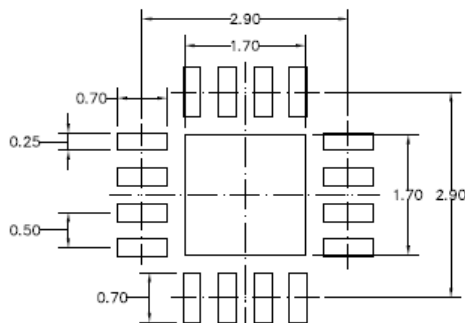
BOTTOM VIEW



SIDE VIEW



SECTION A-A



RECOMMENDED LAND PATTERN

NOTE:

- 1) THE LEAD SIDE IS WETTABLE.
- 2) ALL DIMENSIONS ARE IN MILLIMETERS.
- 3) EXPOSED PADDLE SIZE DOES NOT INCLUDE MOLD FLASH.
- 4) LEAD COPLANARITY SHALL BE 0.08 MILLIMETERS MAX.
- 5) JEDEC REFERENCE IS MO-220.
- 6) DRAWING IS NOT TO SCALE.

APPENDIX A: DEFINITIONS

Effective Resolution (3σ noise level)	This is the smallest angle increment distinguishable from the noise. The resolution is measured by computing three times σ (the standard deviation in degrees) taken over 1,000 data points at a constant position. The resolution in bits is obtained with: $\log_2(360/6\sigma)$.
Refresh Rate	Rate at which new data points are stored in the output buffer.
ABZ Update Rate	Rate at which a new ABZ state is computed. The inverse of this rate is the minimum time between two ABZ edges.
Latency	The time elapsed between the instant when the data is ready to be read and the instant at which the shaft passes that position. The lag in degrees is $lag = latency \cdot v$, where v is the angular velocity in deg/s.
Power-Up Time	Time until the sensor delivers valid data starting at power up.
	Maximum deviation between the average sensor output (at a fixed position) and the true mechanical angle.

Integral (INL)

Non-Linearity

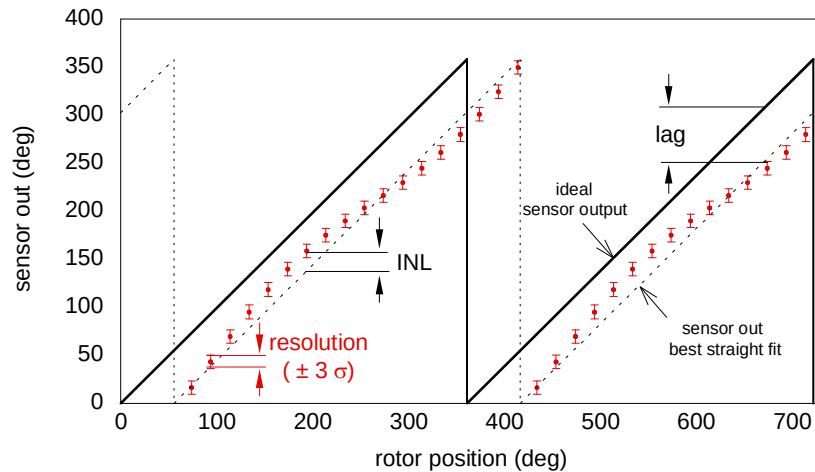


Figure A1: Resolution, INL, Lag

INL can be obtained from the error curve $err(\alpha) = out(\alpha) - \alpha$, where $out(\alpha)$ is the average over 1000 sensor output and α is the mechanical angle indicated by a high precision encoder (<0.001 deg). INL is then computed with Equation (A1):

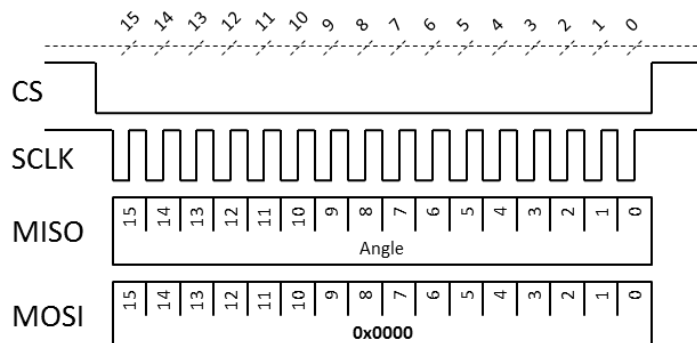
$$INL = \frac{\max(err(\alpha)) - \min(err(\alpha))}{2} \quad (A1)$$

Drift

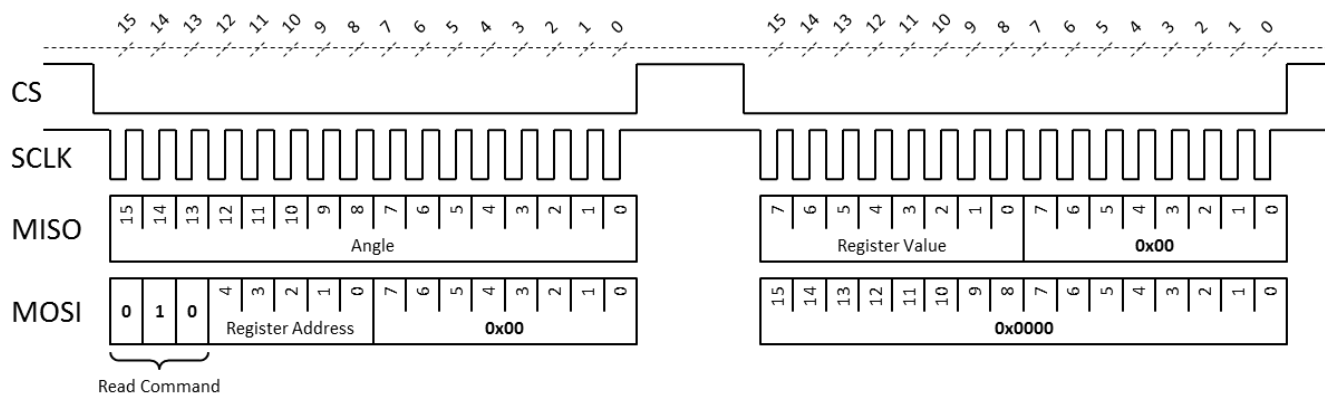
Angle variation rate when one parameter is changed (e.g.: temperature, VDD) and all the others, including the shaft angle, are maintained constant.

APPENDIX B: SPI COMMUNICATION CHEATSHEET

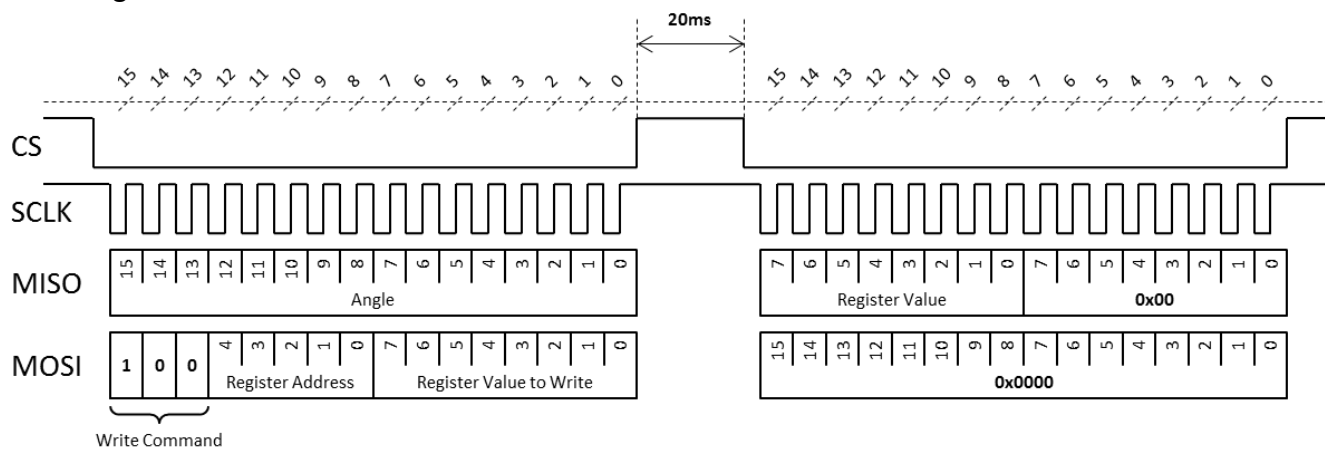
Read Angle



Read Register



Write Register



REVISION HISTORY

Revision #	Revision Date	Description	Pages Updated
1.0	1/21/2019	Initial Release	-
1.1	6/22/2021	Changed operation temperature to 150°C.	1
		Changed maximum junction temperature to 160°C.	3
		Added INL characteristic at 150°C in Electrical Characteristics section.	5
1.2	8/8/2022	Updated legal notice.	1
		Added pull-up resistor parameter in General Characteristics table.	6
		Updated ABZ Jitter, Noise Spectrum, and Non-Linearity plots.	7
		Updated SSI Communication section; updated Table 5.	15
		Updated the MGL hysteresis direction in Figure 25.	21
		Updated Magnetic Field Thresholds section; added MGL Application Note section, MGL Workarounds section, and Table 18.	22
		Updated ABZ Incremental Encoder Output section.	23
		Minor formatting updates.	All

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